

<b>Notice of References Cited</b>	Application/Control No. 09/766,275	Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL.	
	Examiner Jennifer A Boyd	Art Unit 1771	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,372,067	04-2002	Kobayashi et al.	156/73.1
	B	US-6,531,014	03-2003	Kobayashi et al.	156/181
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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